



COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	BV _{DSS}	R _{DS(ON)}	I _D T _A = +25°C
N 01	00)/	$35m\Omega$ @ $V_{GS} = 4.5V$	4.6A
N-Channel	20V	43mΩ @ V _{GS} = 2.5V	4.2A
D. Observati	001/	74mΩ @ V _{GS} = -4.5V	-3.2A
P-Channel	-20V	110mΩ @ V _{GS} = -2.5V	-2.7A

Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Description

This new generation MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

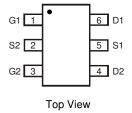
- Backlighting
- DC-DC Converters
- Power Management Functions

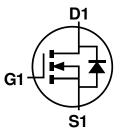
Mechanical Data

- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208@3
- Weight: 0.013 grams (Approximate)

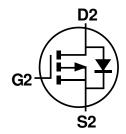








Q1 N-Channel MOSFET



Q2 P-Channel MOSFET

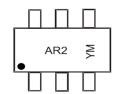
Ordering Information (Note 4)

Part Number	Case	Packaging
DMC2053UVT-7	TSOT26	3000 / Tape & Reel
DMC2053UVT-13	TSOT26	10000 / Tape & Reel

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information



AR2 = Product Type Marking Code YM = Date Code Marking Y or \overline{Y} = Year (ex: F = 2018) M or \overline{M} = Month (ex: 9 = September)

Date Code Key

Year	2017		2018	2019		2020	2021		2022	2023		2024
Code	Е		F	G		Н			J	K		L
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Q1 Value	Q2 Value	Unit		
Drain-Source Voltage	V_{DSS}	20	-20	V		
Gate-Source Voltage	V _{GSS}	±12	±12	V		
Continuous Drain Current (Note 6) V _{GS} = 4.5V	Steady State	$T_A = +25$ °C $T_A = +70$ °C	I _D	4.6 3.7	-3.2 -2.6	А
Maximum Continuous Body Diode Forward Current	I _S	1.4	-1.3	Α		
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%	I _{DM}	22	-20	Α		

Thermal Characteristics

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	$T_A = +25^{\circ}C$	P_{D}	0.7	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{\theta JA}$	173	°C/W
Total Power Dissipation (Note 6)	T _A = +25°C	P _D	1.1	W
Thermal Resistance, Junction to Ambient (Note 6) Steady State		$R_{ heta JA}$	108	°C/W
Thermal Resistance, Junction to Case		$R_{\theta JC}$	37	C/VV
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C

Electrical Characteristics Q1 N-CHANNEL (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV _{DSS}	20	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1.0	μΑ	$V_{DS} = 20V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 12V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(TH)}	0.4		1.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
				35		$V_{GS} = 4.5V, I_D = 5.0A$
Static Drain-Source On-Resistance	R _{DS(ON)}	_	_	43 56	mΩ	$V_{GS} = 2.5V, I_D = 4.0A$
						$V_{GS} = 1.8V, I_D = 2.0A$
Diode Forward Voltage	V_{SD}	_	0.7	1.2	V	$V_{GS} = 0V, I_{S} = 1A$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C _{iss}	I	369	_		V _{DS} = 10V, V _{GS} = 0V f = 1.0MHz
Output Capacitance	Coss		54	_	pF	
Reverse Transfer Capacitance	C _{rss}	_	32	_		1 = 1.01/11 12
Gate Resistance	R_{g}		4.1	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (V _{GS} = 4.5V)	Q_g	_	3.6	_		
Gate-Source Charge	Q _{gs}	_	0.4	_	nC	$V_{GS} = 4.5V, V_{DS} = 10V, I_D = 6A$
Gate-Drain Charge	Q_{gd}	_	1.0	_		
Turn-On Delay Time	t _{D(ON)}	_	2.6	_		
Turn-On Rise Time	t _R	_	3.0	_	ns	$V_{DS} = 10V, V_{GS} = 5V,$
Turn-Off Delay Time	t _{D(OFF)}		12.5	_	ns	$R_G = 6\Omega$, $I_D = 6A$
Turn-Off Fall Time	t _F	_	3.6	_		
Reverse Recovery Time	t _{RR}	_	6.0	_	ns	1 4 4 -11/-14 4 00 4 /
Reverse Recovery Charge	Q _{RR}	_	0.9	_	nC	$I_F = 1A$, di/dt = $100A/\mu s$

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

^{6.} Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

7. Short duration pulse test used to minimize self-heating effect.

^{8.} Guaranteed by design. Not subject to production testing.



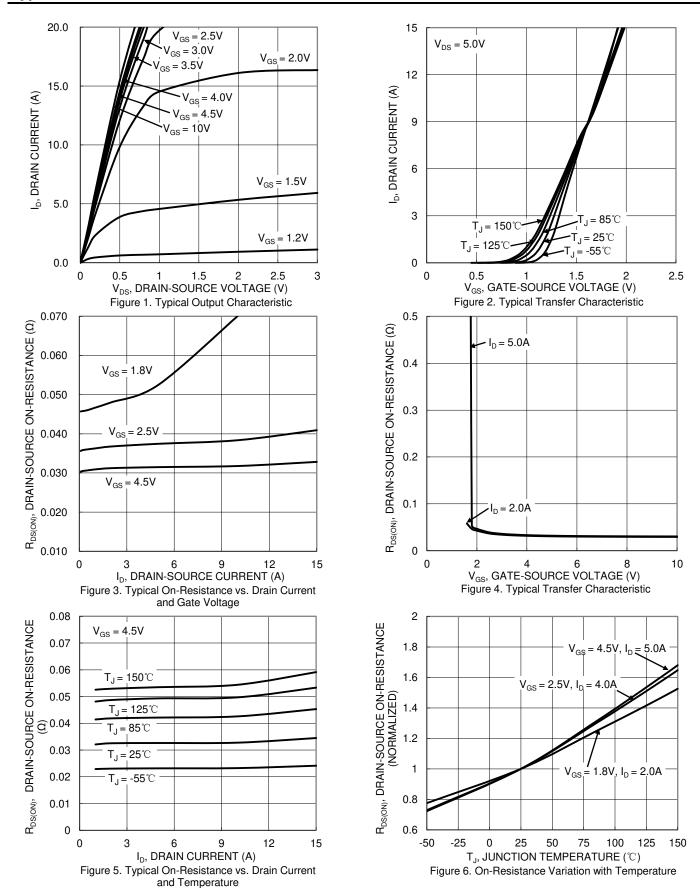
Electrical Characteristics Q2 P-CHANNEL (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	-20		_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	-1.0	μΑ	$V_{DS} = -20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 12V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V _{GS(TH)}	-0.45	_	-1.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
				74		$V_{GS} = -4.5V, I_D = -3.5A$	
Static Drain-Source On-Resistance	R _{DS(ON)}	_	_	110	mΩ	$V_{GS} = -2.5V, I_D = -3.0A$	
	, ,			168		V _{GS} = -1.8V, I _D = -2.0A	
Diode Forward Voltage	V_{SD}	_	-0.8	-1.2	V	$V_{GS} = 0V, I_{S} = -1A$	
DYNAMIC CHARACTERISTICS (Note 8)					•		
Input Capacitance	Ciss		440	_		V _{DS} = -10V, V _{GS} = 0V, f = 1.0MHz	
Output Capacitance	Coss	_	60	_	pF		
Reverse Transfer Capacitance	Crss	_	48	_		I = I.OIVINZ	
Gate Resistance	R_q	_	8.5	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge (V _{GS} = -4.5V)	Qq	_	5.9	_			
Gate-Source Charge	Qgs		0.6	_	nC	$V_{DS} = -4V, I_{D} = -3.5A$	
Gate-Drain Charge	Q_{gd}	_	2.1	_			
Turn-On Delay Time	t _{D(ON)}		3.2	_			
Turn-On Rise Time	t _R		7.8	_		$V_{GS} = -4.5V, V_{DS} = -4V,$	
Turn-Off Delay Time	t _{D(OFF)}	_	31	_	ns	$R_G = 6\Omega$, $R_L = 4\Omega$	
Turn-Off Fall Time	t _F	_	18	_			
Reverse Recovery Time	t _{RR}	_	10.5	_	ns	$I_F = -2.0A$, $di/dt = -100A/\mu s$	
Reverse Recovery Charge	Q _{RR}	_	3.0	_	nC	I _F = -2.0A, di/dt = -100A/μs	

7. Short duration pulse test used to minimize self-heating effect. 8. Guaranteed by design. Not subject to production testing. Notes:

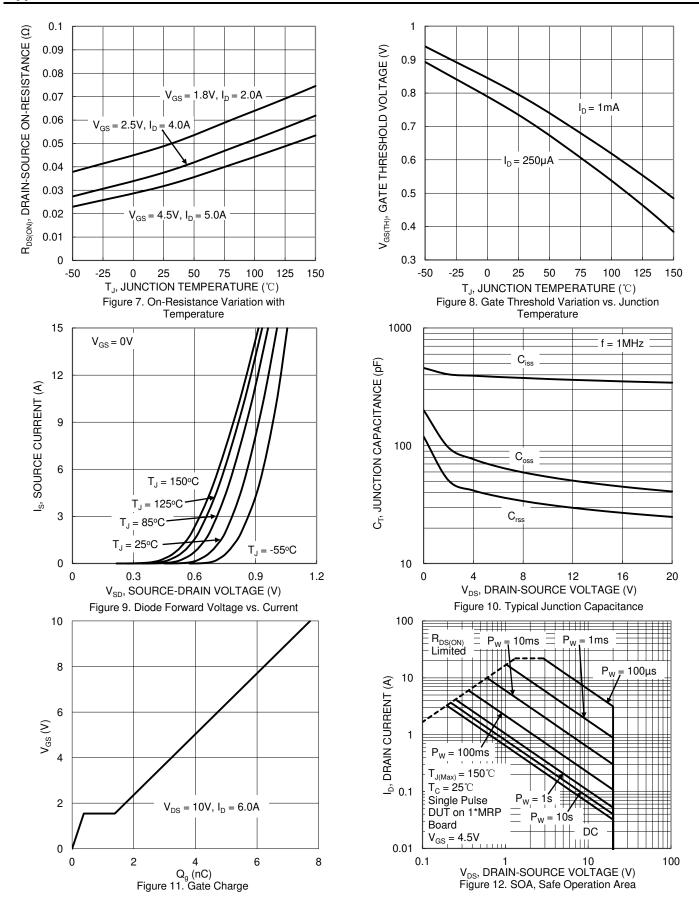


Typical Characteristics - N-CHANNEL



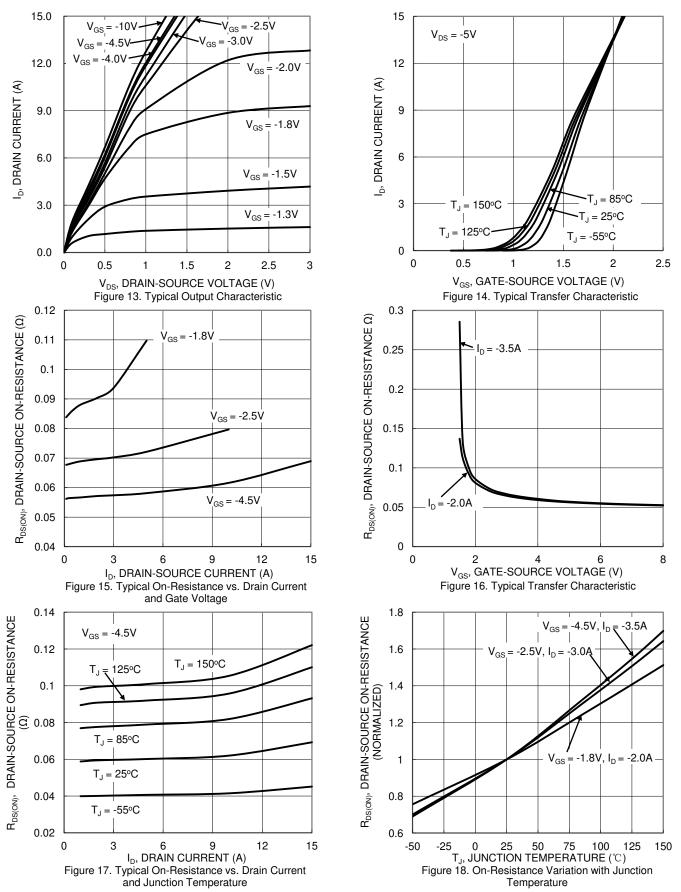


Typical Characteristics - N-CHANNEL (Cont.)



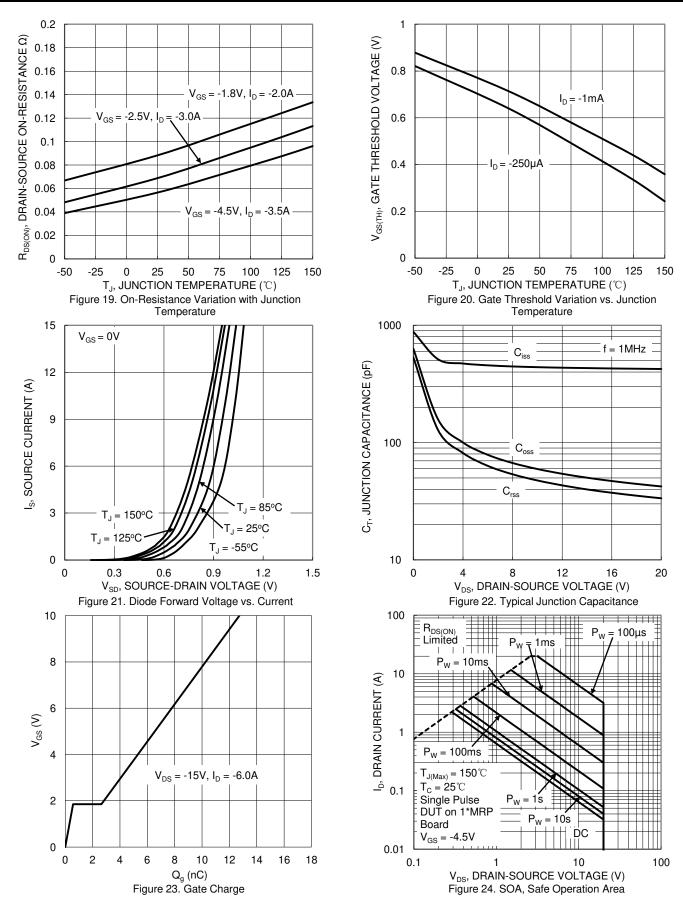


Typical Characteristics - P-CHANNEL





Typical Characteristics - P-CHANNEL (Cont.)





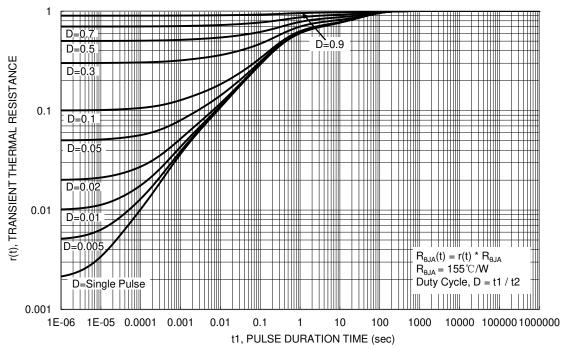


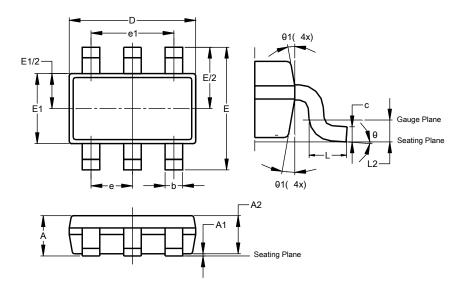
Figure 25. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

TSOT26

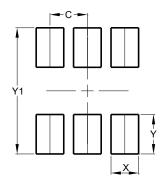


	TSOT26							
Dim	Min	Max	Тур					
Α	-	1.00	-					
A 1	0.010	0.100	-					
A2	0.840	0.900	-					
D	2.800	3.000	2.900					
E	2	2.800 BSC						
E1	1.500	1.700	1.600					
b	0.300	0.450	_					
С	0.120	0.200	-					
е	0.950 BSC							
e1	1	.900 BS	O					
L	0.30	0.50	_					
L2	0	.250 BS	С					
θ	0°	8°	4°					
θ1	4°	12°	_					
Α	All Dimensions in mm							

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

TSOT26



Dimensions	Value (in mm)
С	0.950
Х	0.700
Υ	1.000
Y1	3.199



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